

# SPIRE Technical Note

Ref: SPIRE-RAL-NOT-002284

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SPIRE Short Performance Test sequence for EQM testing B. Swinyard

## Scope

Outline description of the sequence and procedures to be used during the SPIRE CQM Short Performance Test (SPT) once integrated into the Herschel EQM Payload Module at EADS Astrium in Ottobrun. The pre-requisites for the test are briefly described followed by a table setting out the steps in the test sequence; the names of the procedures to be executed from SCOS and the references to any manual procedures required; and the estimated duration of each part of the test.

### **Change notes**

0.1 7 January 2005 Draft for ch

Draft for checking - procedure names to be added/checked

### **Applicable Documents**

AD1 SPIRE Functional Test Specification - SPIRE-RAL-DOC-001652

AD2 SPIRE COOLER RECYCLING SCOS PROCEDURE - SPIRE-RAL-PRC-002267

#### **Reference Documents**

## Prerequisites for carry out the Short Performance Test

FPU is integrated onto HOB

WE integrated with CCE

WE integrated with harness and FPU

Warm functional test done

Cold functional test done at "4K" and "1.7K" as per AD1

FP is at nominal temperature and left in REDY mode – see transition diagram in AD1

#### **Prerequisites for data analysis**

SCOS is running and display screens are available with conversion curves loaded

QLA sequences ready for display of data and FITS output

IDL present on local machine (laptop if necessary) with access to FITS filestore via FTP or other method

### **Outline Test sequence:**

Step	Description	Procedure Name	Estimated Duration
1	Check the noise in the PLW JFETs with shorted inputs versus Vss (detectors at ~2K)	FUNC-DCU-07P (AD1)	30 minutes
2	Noise versus bias using spectrometer side of instrument and STM JFETS	FUNC-DCU-10S (AD1)	30 minutes
3	Analyse data – verify no excess system noise	BMS IDL code	
	Th	ermal case 1	
4	Recycle cooler	COOLER RECYCLE (AD2)	2 hours
5	Switch to Photometer Standby	Procedure name? Requires manual procedure to set equivalent power in BSM coils	10 minutes



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Step	Description	Procedure Name	Estimated		
			Duration		
6	Wait until temperature stabilises	N/A	TBD		
6a	During stabilisation we can check	DNA-P Procedure name?	4 hours		
	noise versus bias level and frequency		max		
	with reduced number of bias levels				
	and frequencies or it will take all day				
7	Analyse data – determine noise is	BMS/TLL IDL code			
	o.k. and optimum frequency setting				
	– analysis procedure exists				
0	Evaporator temperature must have stabilised before next test				
8	Set for clean bias frequency and	By Manual Command	10		
0	nominal bias (~15 mV)	Finia Bay oop a u	minutes		
9	Phase up to maximise signal	FUNC-DCU-08P_full	30		
		FUNC-DCU-08P_short	minutes		
10	T 1 (C 1C 1	(AD1)	(TBC)		
10	Loadcurve at fixed frequency and	Mode_ILT_PERF_DAL_P_SinglePhase	15		
	phase		minutes		
1.1	Loadoums of fived fragments and	Mode II T DEDE DAI D CircleDhess	(TBC)		
11	Loadcurve at fixed frequency and phase+90	Mode_ILT_PERF_DAL_P_SinglePhase	15 minutes		
	phase+90		(TBC)		
12	Loadcurve at fixed frequency and	Mode_ILT_PERF_DAL_P_SinglePhase	15		
12	phase-90	Wode_IL1_I ER1_DAL_I _Shigler hase	minutes		
	phase 90		(TBC)		
13	Analyse data – determine detector	BMS IDL code	(IBC)		
	temperature and estimate				
	background loading				
14	Set detector for optimum bias setting	By Manual Command	10		
			minutes		
15	Rephase detector at optimum bias	FUNC-DCU-08P_short	10		
	setting	(AD1)	minutes		
16	Run PCAL static test to check	Mode_ILT_PERF_CPS_P	15		
	calibration against CBB		minutes		
			(TBC)		
17	- Analyse data – determine absolute	Analysis code required			
	signal versus voltage calibration –				
	Can now use SPIRE to determine	Analysis code required			
	ambient background for (almost) any				
	setting of the cryo-cover	there there are a second			
10		other thermal cases			
18 19	Photometer scan mode	No procedure required			
17	Photometer chop mode	Requires procedure to manually apply power to BSM using external (GSE)			
		supply			
20	Switch photometer to spectrometer	Procedure required			
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Step	Description	Procedure Name	Estimated				
			Duration				
21	Spectrometer mode	Requires procedure to manually power					
		to SMEC using external (GSE) supply					
	Wait for cooler exhaustion approx 30-32 hours after recycle						
	SPIRE/PACS parallel mode test						
22	Second Cooler recycle in	COOLER RECYCLE	Start 25				
	conjunction with PACS	(AD2)	minutes				
	-	See also SPIRE-RAL-NOT-002283	after				
			PACS				
			recycle				
			Then 2				
			hours				
23	Switch to SPIRE Photometer	Procedure name?	10				
	Standby	Requires manual procedure to set	minutes				
		equivalent power in BSM coils	(TBC)				
24	Switch to SPIRE Parallel (scan)	Procedure to request full photometer	1 minute				
		data at 10 Hz					
	Wait until temperatures have stabilised						
25	Switch to SPIRE Parallel (chop)	Procedure will not be quite flight like –	10				
	-	keep 10 Hz continuous sample and	minutes				
		manually apply power to BSM coils via					
		external (GSE) supply					
	Other PACS modes?						
	Wait for cooler exhaustion						
	Then EMC tes	ts – see separate procedure					